

# Search Notes



Application/Control No.

10/786,811

Examiner

Dawn Garrett

Applicant(s)/Patent under Reexamination

ZHENG ET AL.

Art Unit

1774

## SEARCHED

Class	Subclass	Date	Examiner
428	690	10/18/06	DS
428	917		
313	504		
313	506		
257	40		
427	66		
(see EAST search puntout)			

## INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

## SEARCH NOTES (INCLUDING SEARCH STRATEGY)

	DATE	EXMR
Inventor Name Search	10/18/06	DS
EAST search (see attached puntout)	10/18/06	DS
STIC-EIC search of structure (see puntout)	5/2005	DS
STIC search (see puntout)	2/20/07 AND 2/22/07	DS